TYPICAL ANALYSIS DEPTHS FOR TECHNIQUES

- Physical Monolayer: 3 nm
  - Top Surface
  - Near Surface
- Thin Film: 10 nm
- Thick Film: 100 nm
- Bulk Substrate: 1,000 nm
- >2,000 nm

Techniques:
- AFM
- Atom Probe
- Auger
- DHEM
- Dilatometry
- DSC
- DTA
- EBSD
- EDS
- EELS
- Electrochemistry
- Ellipsometry
- FIB
- FTIR
- GC-MS
- GDMS
- GPC
- HALT/MEOST
- HFS
- IC
- ICP-MS
- ICP-OES
- IGA
- LA-ICPMS
- LC-MS
- LIBS
- MALDI
- Mechanical
- Nanoindentation
- NMR
- OP
- Raman
- RBS
- Refractometry
- RTX
- SEM-CL
- SEM, EBIC
- SIMS
- (S)TEM
- Tensiometry
- TGA
- TOF-SIMS
- TXRF, XRF
- Viscometry
- XPS
- XRD, XRR

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